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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Confirmation No. 1821

Mitsuhiro OKUNE et al.

Attorney Docket No. 2006 0772A

Serial No. 10/581,256

Group Art Unit 1765

Filed May 31, 2006

THE COMMISSIONER IS AUTHORIZED TO CHARGE ANY DEFICIENCY IN THE FEES FOR THIS PAPER TO DEPOSIT

PLASMA ETCHING METHOD

ACCOUNT NO. 23-0975

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to the provisions of 37 CFR 1.56, 1.97 and 1.98, Applicants request consideration of the references listed on attached form PTO-1449 and any additional information identified below in paragraph 3. A legible copy of each reference listed on the Form PTO-1449 is enclosed, except a copy is not provided for:

	[X]	each U.S. Patent and U.S. Patent application publication;						
	0	each reference previously cited in the international application PCT/; and/or						
	0	each reference previously cited in prior parent application Serial No.						
la.	[X] Thi	is Information Disclosure Statement is submitted:						

within three months of the filing date (or of entry into the National Stage) of the above-entitled application, or

before the mailing of a first Office Action on the merits or the mailing of a first Office Action after the filing of an RCE,

and thus no certification and/or fee is required.

after the events of above paragraph 1a and prior to the mailing date of a final Office Action or a Notice of Allowance or an action which otherwise closes prosecution in the application, and thus:

- (1) [] the certification of paragraph 2 below is provided, or
- (2) [] the fee of \$180.00 specified in 37 CFR 1.17(p) is enclosed.
- 1c. [] This Information Disclosure Statement is submitted:

after the mailing date of a final Office Action or Notice of Allowance or action which otherwise closes prosecution in the application, and prior to payment of the issue fee, and thus:

the certification of paragraph 2 below is provided, and

the fee of \$180.00 specified in 37 CFR 1.17(p) is enclosed.

- 2. It is hereby certified
 - a. [] that each item of information contained in this Information Disclosure

 Statement was first cited in any communication from a foreign patent office in a

 counterpart foreign application not more than three months prior to the filing of
 the Statement, or
 - b. [] that no item of information contained in the Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application and, to the knowledge of the person signing the certification after making reasonable inquiry, was known to any individual designated in §1.56(c) more than three months prior to the filing of the Statement.
- 3. [] Consideration of the following list of additional information (including any copending or abandoned U.S. application, prior uses and/or sales, etc.) is requested.
- 4. For each non-English language reference listed on the attached form PTO-1449, reference is made to:
 - a. [X] a full or partial English language translation submitted herewith,

- b. [] a foreign patent office search report (in the English language) submitted herewith,
- c. [] the concise explanation contained in the specification of the present application at page,
- d. [X] the concise explanation set forth in the attached English language abstract,
- e. [X] the concise explanation set forth below or on a separate sheet attached to the reference:

JP 8-250482 corresponds to U.S. 5,762,813; JP 2003-100710 corresponds to U.S. 6,893,971, 2003/066817, and 2005/161160;

U.S. 6,191,043 corresponds to JP 2002-542623 (previously cited);

U.S. 2002/014662 corresponds to JP 2003-284283 (previously cited);

U.S. 6,521,538 corresponds to JP 2001-244325 (previously cited); and

U.S. 6,833,079 corresponds to JP 2003-533869 (previously cited).

- 5. [X] Foreign patent office Office Actions (issued in connection with the Japanese Priority applications) citing one or more of the references is enclosed.
- 6. [] Statement Under 37 CFR 1.704(d)

Each item of information contained in the Information Disclosure Statement was first cited in any communication from a foreign Patent Office in a counterpart application, and this communication was not received by any individual designated in §1.56(c) more than thirty days prior to the filing of the Information Disclosure Statement.

Respectfully submitted,

Mitsuhiro OKUNE et al.

By Charles R. Watts

Registration No. 33,142

Attorney for Applicants

CRW/asd Washington, D.C. 20006-1021 Telephone (202) 721-8200 Facsimile (202) 721-8250 May 24, 2007

**Sheet 1 of 1				TION DISCLOS	URE STATEMENT		OIPE				
FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE				ATTY DOCKET NO. 2006_0772A SERIAL NO. 10/581,256			24:2007				
PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)				APPLICANT Mitsuhiro OKUNE et al.							
(Use several sheets if necessary) Date Submitted to PTO: May 24, 2007					FILING DATE May 31, 2006 GROUP 1765						
U.S. PATENT DOCUMENTS											
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME CLASS		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE			
	AA	6,191,043	2/2001	McF	McReynolds						
	AB	2002/0014662	2/2002	Yama	ızaki et al.						
	AC	5,762,813	6/1998	Takiy	ama et al.						
	AD	6,521,538	2/2003	So	ga et al.						
	AE	6,833,079	12/2004	G	ordani						
	AF	6,893,971	5/2005	Tana	abe et al.						
	AG	2003/0066817	4/2003	Tana	abe et al.						
	AH	2005/0161160	7/2005	Tana	abe et al.			····			
	Al										
			FORE	IGN PATENT	DOCUMENTS						
		DOCUMENT NUMBER	DATE	cc	DUNTRY	CLASS SUBCLASS TRANSLATION YES NO		TION NO			
	AJ	11-150180	6/1999	JP				Abstract & Partial Translation			
	AK	8-250482	9/1996		JP	40		Abstract			
	AL	2003-100710	4/2003	JP				Abstract			
	AM										
	AN										
	АО										
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)											
	AP										
	AQ										
EXAMINER			DATE CONSIDERED	RED							

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copthis form with next communication to applicant.